CD54HC646...F PACKAGE

SCHS278B - APRIL 2003 - REVISED APRIL 2003

- 2-V to 6-V V<sub>CC</sub> Operation (CD54HC646)
- 4.5-V to 5.5-V V<sub>CC</sub> Operation (CD74HCT646)
- Wide Operating Temperature Range of -55°C to 125°C
- Balanced Propagation Delays and Transition Times
- Standard Outputs Drive Up To 15 LS-TTL
  l oads
- Significant Power Reduction Compared to LS-TTL Logic ICs
- Inputs Are TTL-Voltage Compatible (CD74HCT646)
- Independent Registers for A and B Buses
- Multiplexed Real-Time and Stored Data
- True Data Paths

#### CD74HCT646...M PACKAGE (TOP VIEW) 24 🛮 V<sub>CC</sub> CLKAB [ SAB II 2 23 CLKBA DIR $\Pi$ 3 22**∏** SBA 21 TOE A1 **∏** 4 A2 **∏** 5 20**∏** B1 19**∏** B2 A3 ∏ 6 А4 Г 18**∏** B3 A5 **∏** 8 17**∏** B4 A6 🛮 9 16 B5 A7 **∏** 10 15**∏** B6 A8 **∏** 11 14**∏** B7 12 13 B8 GND ∏

## description/ordering information

The CD54HC646 and CD74HCT646 consist of bus-transceiver circuits with 3-state outputs, D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the input bus or from the internal registers. Data on the A or B bus is clocked into the registers on the low-to-high transition of the appropriate clock (CLKAB or CLKBA) input. Figure 1 illustrates the four fundamental bus-management functions that can be performed with these devices.

Output-enable ( $\overline{OE}$ ) and direction-control (DIR) inputs control the transceiver functions. In the transceiver mode, data present at the high-impedance port can be stored in either or both registers.

The select-control (SAB and SBA) inputs can multiplex stored and real-time (transparent mode) data. DIR determines which bus receives data when  $\overline{OE}$  is active (low). In the isolation mode ( $\overline{OE}$  high), A data can be stored in one register and/or B data can be stored in the other register.

When an output function is disabled, the input function still is enabled and can be used to store data. Only one of the two buses, A or B, can be driven at a time.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

#### **ORDERING INFORMATION**

TA	PAC	KAGE <sup>†</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING
–55°C to 125°C	SOIC - M	Tape and reel	CD74HCT646M96	HCT646M
-55 C to 125 C	CDIP – F	Tube	CD54HC646F3A	CD54HC646F3A

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



SCHS278B - APRIL 2003 - REVISED APRIL 2003

#### **FUNCTION TABLE**

		INP	UTS			DAT	A I/O	OPERATION OR FUNCTION
ŌĒ	DIR	CLKAB	CLKBA	SAB	SBA	A1-A8	B1-B8	OPERATION OR FUNCTION
Х	Х	1	Х	Х	Х	Input	Unspecified†	Store A, B unspecified <sup>†</sup>
Х	X	Χ	<b>↑</b>	X	Χ	Unspecified <sup>†</sup>	Input	Store B, A unspecified <sup>†</sup>
Н	Х	1	1	Х	Х	Input Input		Store A and B data
Н	Х	H or L	H or L	Х	Χ	Input disabled	Input disabled	Isolation, hold storage
L	L	Х	Х	Х	L	Output	Input	Real-time B data to A bus
L	L	Χ	H or L	Х	Н	Output	Input	Stored B data to A bus
L	Н	Х	Х	L	Х	Input	Output	Real-time A data to B bus
L	Н	H or L	Χ	Н	Χ	Input	Output	Stored A data to B bus

<sup>†</sup> The data-output functions can be enabled or disabled by various signals at  $\overline{\text{OE}}$  and DIR. Data-input functions always are enabled; i.e., data at the bus terminals is stored on every low-to-high transition of the clock inputs.



SCHS278B - APRIL 2003 - REVISED APRIL 2003

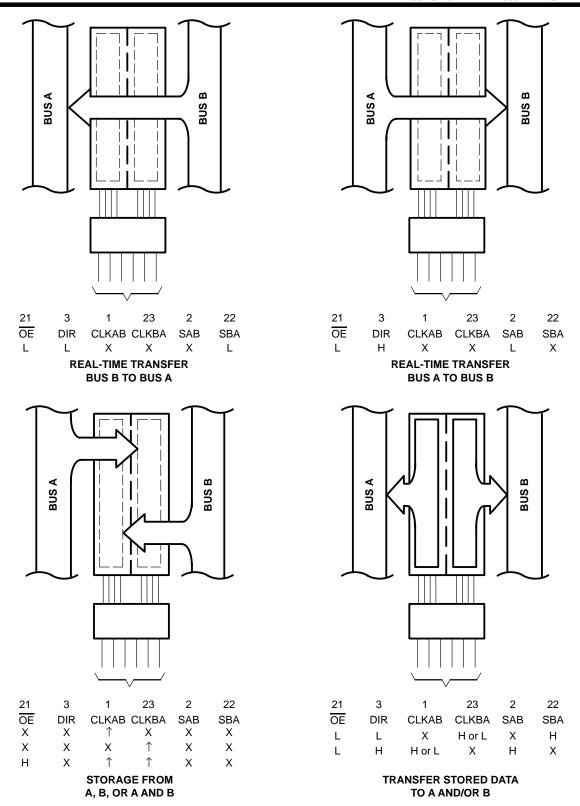
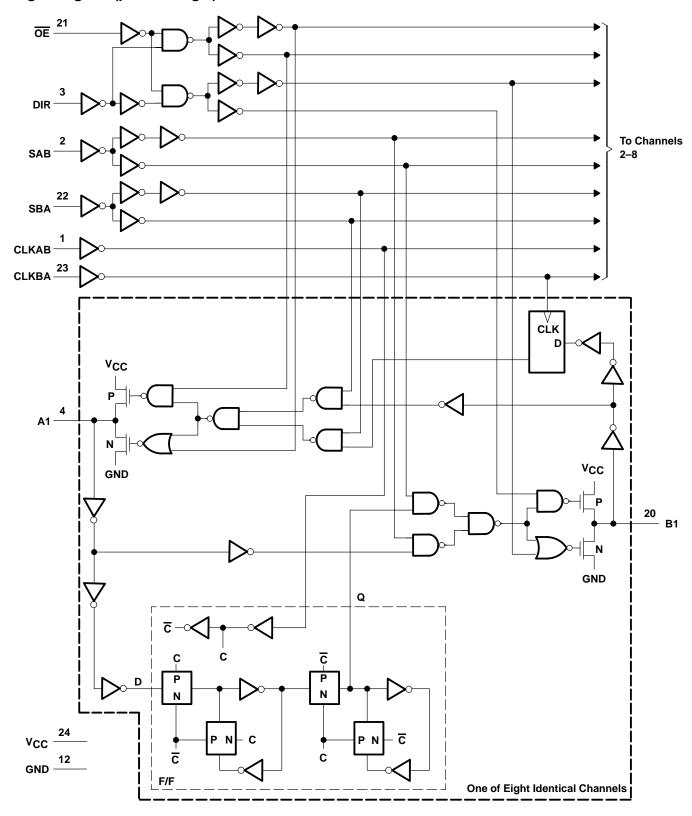


Figure 1. Bus-Management Functions



## logic diagram (positive logic)





SCHS278B - APRIL 2003 - REVISED APRIL 2003

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	0.5 V to 7 V
Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{CC}$ ) (see Note 1)	±20 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> ) (see Note 1)	±20 mA
Continuous output drain current per output, I <sub>O</sub> (V <sub>O</sub> = 0 to V <sub>CC</sub> )	±35 mA
Continuous current through V <sub>CC</sub> or GND	±50 mA
Package thermal impedance, $\theta_{JA}$ (see Note 2) M package	46°C/W
Storage temperature range, T <sub>stq</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## recommended operating conditions for CD54HC646 (see Note 3)

			MIN	MAX	UNIT
Vcc	Supply voltage		2	6	V
	Vcc	= 2 V	1.5		
٧ <sub>IH</sub>	High-level input voltage	= 4.5 V	3.15		V
	Vcc	= 6 V	4.2		
	Vcc	= 2 V		0.5	
VIL	Low-level input voltage	= 4.5 V		1.35	V
	Vcc	= 6 V		1.8	
٧ <sub>I</sub>	Input voltage		0	VCC	V
٧o	Output voltage		0	VCC	V
	Vcc	= 2 V		1000	
t <sub>t</sub>	Input transition (rise and fall) time	= 4.5 V		500	ns
	V <sub>CC</sub> = 6 V			400	
TA	Operating free-air temperature		-55	125	°C

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

## recommended operating conditions for CD74HCT646 (see Note 3)

		MIN	MAX	UNIT
Vcc	Supply voltage	4.5	5.5	V
VIH	High-level input voltage	2		V
V <sub>IL</sub>	Low-level input voltage		0.8	V
٧ <sub>I</sub>	Input voltage		VCC	V
Vo	Output voltage		VCC	V
t <sub>t</sub>	Input transition (rise and fall) time		500	ns
TA	Operating free-air temperature	-55	125	°C

NOTE 4: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>2.</sup> The package thermal impedance is calculated in accordance with JESD 51-7.

SCHS278B - APRIL 2003 - REVISED APRIL 2003

## electrical characteristics for CD54HC646 over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		vcc	T <sub>A</sub> = 1	25°C	T <sub>A</sub> = -		T <sub>A</sub> = −40°C TO 85°C		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX		
			2 V	1.9		1.9		1.9		
		$I_{OH} = -20  \mu A$	4.5 V	4.4		4.4		4.4		
Voн	VI = VIH or VIL		6 V	5.9		5.9		5.9		V
		$I_{OH} = -6 \text{ mA}$	4.5 V	3.98		3.7		3.84		
		$I_{OH} = -7.8 \text{ mA}$	6 V	5.48		5.2		5.34		
		I <sub>OL</sub> = 20 μA	2 V		0.1		0.1		0.1	
			I <sub>OL</sub> = 20 μA	4.5 V		0.1		0.1		0.1
V <sub>OL</sub>	$V_I = V_{IH}$ or $V_{IL}$		6 V		0.1		0.1		0.1	V
		$I_{OL} = 6 \text{ mA}$	4.5 V		0.26		0.4		0.33	
		$I_{OL} = 7.8 \text{ mA}$	6 V		0.26		0.4		0.33	
lį	$V_I = V_{CC}$ or 0		6 V		±0.1		±1		±1	μΑ
loz	VO = VCC or 0		6 V		±0.5		±10		±5	μΑ
ICC	$V_I = V_{CC}$ or 0,	IO = 0	6 V		8		160		80	μΑ
Ci					10		10		10	pF
Co					20		20		20	pF

## electrical characteristics for CD74HCT646 over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CON	Vcс	T <sub>A</sub> = 25°C			T <sub>A</sub> = -		T <sub>A</sub> = -40°C TO 85°C		UNIT	
			MIN	TYP	MAX	MIN	MAX	MIN	MAX		
Voн	VI = VIH or VIL	$I_{OH} = -20  \mu A$	4.5 V	4.4			4.4		4.4		V
VOH	VI = VIH OI VIL	$I_{OH} = -6 \text{ mA}$	4.5 V	3.98			3.7		3.84		V
Val	VI = VIH or VIL	$I_{OL} = 20 \mu A$	4.5 V			0.1		0.1		0.1	V
VOL	AI = AIH OL AIL	$I_{OL} = 6 \text{ mA}$	4.5 V			0.26		0.4		0.33	V
ΙĮ	$V_I = V_{CC}$ to GND		5.5 V			±0.1		±1		±1	μΑ
loz	VO = VCC or 0		5.5 V			±0.5		±10		±5	μΑ
Icc	$V_I = V_{CC}$ or 0,	I <sub>O</sub> = 0	5.5 V			8		160		80	μΑ
∆l <sub>CC</sub> †	One input at V <sub>CC</sub> – 2.1 V, Other inputs at 0 or V <sub>CC</sub>		4.5 V to 5.5 V		100	360		490		450	μΑ
C <sub>i</sub>						10		10		10	pF
Co						20		20		20	pF

<sup>&</sup>lt;sup>†</sup> Additional quiescent supply current per input pin, TTL inputs high, 1 unit load



SCHS278B - APRIL 2003 - REVISED APRIL 2003

#### **HCT INPUT LOADING TABLE**

INPUT	UNIT LOAD
ŌĒ	1.3
DIR	0.75
CLKAB or CLKBA	0.6
SAB or SBA	0.45
A or B	0.3

<sup>†</sup>Unit Load is  $\Delta I_{CC}$  limit specified in electrical characteristics table (e.g., 360  $\mu$ A max at 25°C).

## timing requirements for CD54HC646 over recommended operating free-air temperature range (unless otherwise noted) (see Figure 2)

		vcc	T <sub>A</sub> = 25°C		T <sub>A</sub> = -55°C TO 125°C		T <sub>A</sub> = -40°C TO 85°C		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
		2 V		6		4		5	
fclock	Clock frequency	4.5 V		30		20		25	MHz
		6 V		35		23		29	
			80		120		100		
t <sub>W</sub>	Pulse duration, CLKBA or CLKAB high or low	4.5 V	16		24		20		ns
		6 V	14		20		17		
		2 V	60		90		75		
t <sub>su</sub>	Setup time, A before CLKAB↑ or B before CLKBA↑	4.5 V	12		18		15		ns
		6 V	10		15		13		
		2 V	35		55		45		
th	Hold time, A after CLKAB↑ or B after CLKBA↑	4.5 V	7		11		9		ns
		6 V	6		9		8		

## timing requirements for CD74HCT646 over recommended operating free-air temperature range, $V_{CC}$ = 4.5 V (unless otherwise noted) (see Figure 3)

		T <sub>A</sub> =	T <sub>A</sub> = 25°C		T <sub>A</sub> = -55°C TO 125°C		40°C 5°C	UNIT
		MIN			MAX	MIN	MAX	
fclock	Clock frequency		25		17		20	MHz
t <sub>W</sub>	Pulse duration, CLKBA or CLKAB high or low	25		38		31		ns
t <sub>su</sub>	Setup time, A before CLKAB↑ or B before CLKBA↑	12		18		15		ns
th	Hold time, A after CLKAB↑ or B after CLKBA↑	5	·	5		5		ns

SCHS278B - APRIL 2003 - REVISED APRIL 2003

## switching characteristics for CD54HC646 over recommended operating free-air temperature range (unless otherwise noted) (see Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	Vcc	T,	<sub>A</sub> = 25°C	;	T <sub>A</sub> = -	-55°C 25°C	T <sub>A</sub> = -		UNIT											
	(IIVI O1)	(0011 01)	CALACITANCE		MIN	TYP	MAX	MIN	MAX	MIN	MAX												
				2 V	6			4		5													
f			C <sub>L</sub> = 50 pF	4.5 V	30			20		25		MHz											
fmax				6 V	35			23		29		IVII IZ											
			C <sub>L</sub> = 15 pF	5 V		60																	
				2 V			220		330		275												
	CLKBA or	A or B	C <sub>L</sub> = 50 pF	4.5 V			44		66		55												
	CLKAB	7015		6 V			37		56		47												
			C <sub>L</sub> = 15 pF	5 V		18																	
				2 V			135		205		170												
<b>.</b>	A or B	B or A	C <sub>L</sub> = 50 pF	4.5 V			27		41		34	no											
<sup>t</sup> pd	AUID	BOIX		6 V			23		35		29	ns											
			C <sub>L</sub> = 15 pF	5 V		12																	
		or A an D		2 V			170		255		215												
	SBA or		A or D	A or B	A or B	A or B	A or B	A or B	A or B	A or B	A or B	A or B	A or B	A or B	C <sub>L</sub> = 50 pF	4.5 V			34		51		43
	SAB†	AUID		6 V			29		43		37												
			C <sub>L</sub> = 15 pF	5 V		14																	
				2 V			175		265		220												
	ŌĒ	A or B	C <sub>L</sub> = 50 pF	4.5 V			35		53		44												
<sup>t</sup> en	OE	AUID		6 V			30		45		37	ns											
			C <sub>L</sub> = 15 pF	5 V		14																	
				2 V			175		265		220												
<b>4</b>	ŌĒ	A == D	C <sub>L</sub> = 50 pF	4.5 V			35		53		44												
<sup>t</sup> dis	OE	A or B		6 V			30		45		37	ns											
			C <sub>L</sub> = 15 pF	5 V		14																	
				2 V			60		90		75												
t <sub>t</sub>		Any	C <sub>L</sub> = 50 pF	4.5 V			12		18		15	ns											
				6 V			10		15		13												

<sup>†</sup> These parameters are measured with the internal output state of the storage register opposite that of the bus input.



SCHS278B - APRIL 2003 - REVISED APRIL 2003

## switching characteristics for CD74HCT646 over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	Vcc	T,	դ = 25°C	;	T <sub>A</sub> = -		T <sub>A</sub> = -		UNIT
	(INFOT)	(001F01)	CAFACITANCE	,	MIN	TYP	MAX	MIN	MAX	MIN	MAX	
4			C <sub>L</sub> = 50 pF	4.5 V	25			17		20		MHz
f <sub>max</sub>			C <sub>L</sub> = 15 pF	5 V		45						IVITIZ
	CLKBA or	A or B	$C_{L} = 50 \text{ pF}$	4.5 V			44		66		55	
	CLKAB	AUID	C <sub>L</sub> = 15 pF	5 V		18						
<b>.</b> .	A or B	B or A	$C_L = 50 pF$	4.5 V			37		56		46	ns
<sup>t</sup> pd	AUID	BULA	C <sub>L</sub> = 15 pF	5 V		15						115
	SBA or	A or B	$C_L = 50 pF$	4.5 V			46		69		58	
	SAB†	AUID	C <sub>L</sub> = 15 pF	5 V		19						
	ŌĒ	A or B	$C_{L} = 50 \text{ pF}$	4.5 V			45		68		56	ns
<sup>t</sup> en	OE	AUID	C <sub>L</sub> = 15 pF	5 V		19						115
+	ŌĒ	A or B	C <sub>L</sub> = 50 pF	4.5 V			35		53		44	ns
<sup>t</sup> dis	OE	AUID	C <sub>L</sub> = 15 pF	5 V		14						115
t <sub>t</sub>			$C_{L} = 50 \text{ pF}$	4.5 V			12		18		15	ns

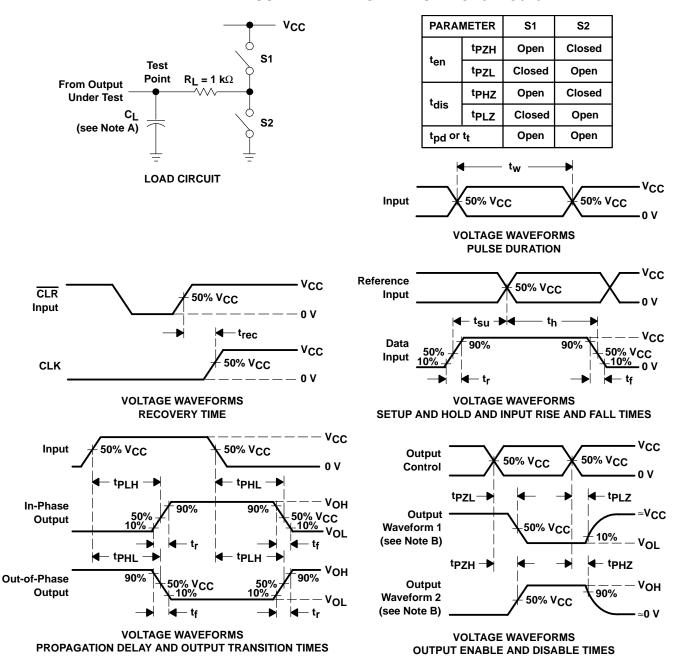
<sup>†</sup> These parameters are measured with the internal output state of the storage register opposite that of the bus input.

## operating characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25^{\circ}\text{C}$

	PARAMETER			
Ср	Power dissipation capacitance	52	pF	



#### PARAMETER MEASUREMENT INFORMATION - CD54HC646

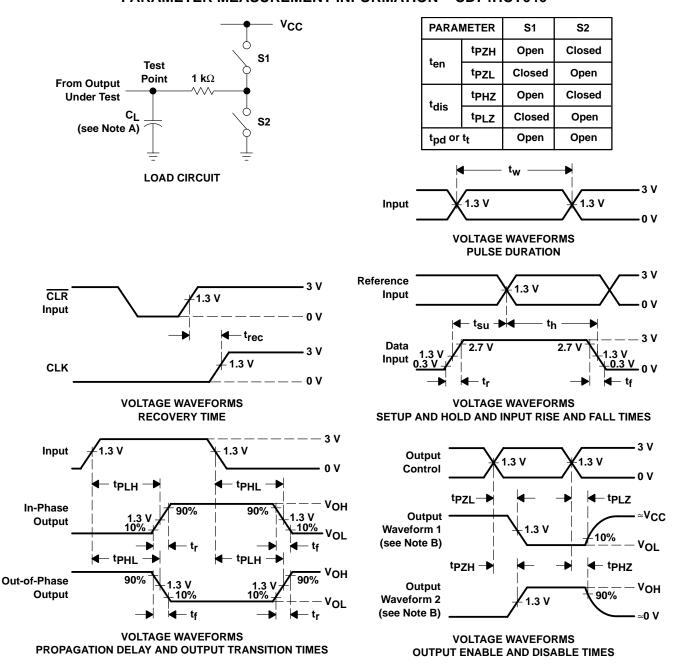


- NOTES: A. C<sub>L</sub> includes probe and test-fixture capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O$  = 50  $\Omega$ ,  $t_f$  = 6 ns,  $t_f$  = 6 ns.
  - D. For clock inputs, f<sub>max</sub> is measured with the input duty cycle at 50%.
  - E. The outputs are measured one at a time with one input transition per measurement.
  - F. tpLz and tpHz are the same as tdis.
  - G. tpzi and tpzH are the same as ten.
  - H. tpLH and tpHL are the same as tpd.

Figure 2. Load Circuit and Voltage Waveforms



### PARAMETER MEASUREMENT INFORMATION - CD74HCT646



NOTES: A. C<sub>L</sub> includes probe and test-fixture capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub> = 6 ns.
- D. For clock inputs,  $f_{\text{max}}$  is measured with the input duty cycle at 50%.
- E. The outputs are measured one at a time with one input transition per measurement.
- F. tpLz and tpHz are the same as tdis.
- G.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- H. tplH and tpHL are the same as tpd.

Figure 3. Load Circuit and Voltage Waveforms







25-Sep-2013

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)		(3)		(4/5)	
5962-8688501JA	ACTIVE	CDIP	J	24	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	5962-8688501JA CD54HC646F3A	Samples
CD54HC646F3A	ACTIVE	CDIP	J	24	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	5962-8688501JA CD54HC646F3A	Samples
CD74HCT646M96	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT646M	Samples
CD74HCT646M96E4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT646M	Samples
CD74HCT646M96G4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT646M	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



## PACKAGE OPTION ADDENDUM

25-Sep-2013

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF CD54HC646:

Catalog: CD74HC646

NOTE: Qualified Version Definitions:

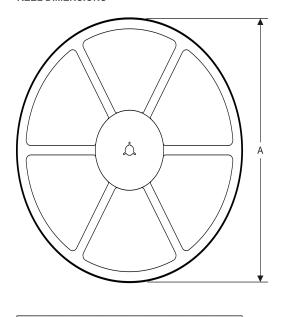
Catalog - TI's standard catalog product

## PACKAGE MATERIALS INFORMATION

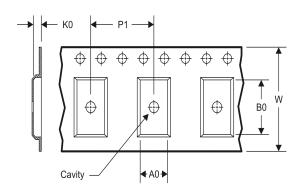
www.ti.com 14-Jul-2012

## TAPE AND REEL INFORMATION

### **REEL DIMENSIONS**



### **TAPE DIMENSIONS**



A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

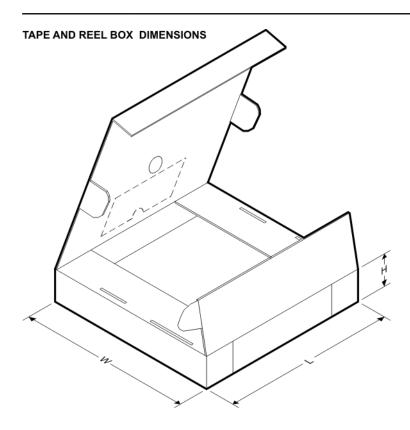
### TAPE AND REEL INFORMATION

### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HCT646M96	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1

**PACKAGE MATERIALS INFORMATION** 

www.ti.com 14-Jul-2012



#### \*All dimensions are nominal

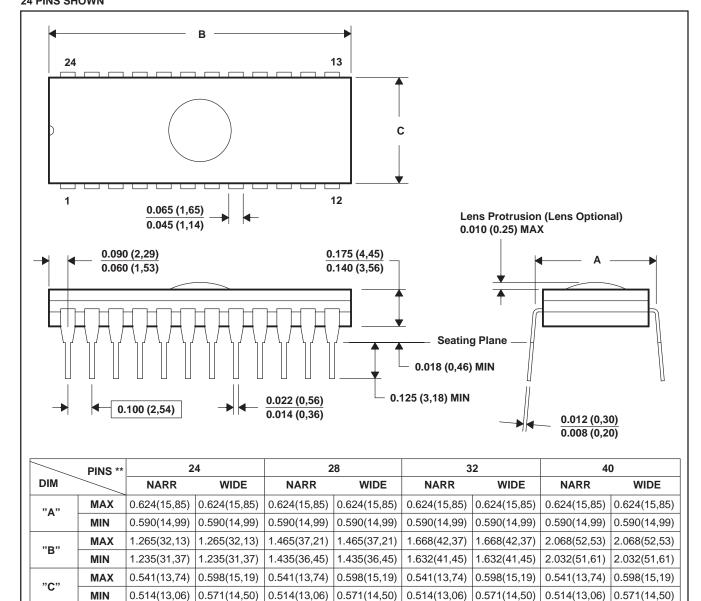
ĺ	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
I	CD74HCT646M96	SOIC	DW	24	2000	367.0	367.0	45.0	

4040084/C 10/97

### J (R-GDIP-T\*\*)

### 24 PINS SHOWN

## **CERAMIC DUAL-IN-LINE PACKAGE**



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Window (lens) added to this group of packages (24-, 28-, 32-, 40-pin).
- D. This package can be hermetically sealed with a ceramic lid using glass frit.
- E. Index point is provided on cap for terminal identification.



DW (R-PDSO-G24)

## PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



#### IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

### Products Applications

Audio www.ti.com/audio Automotive and Transportation www.ti.com/automotive Communications and Telecom **Amplifiers** amplifier.ti.com www.ti.com/communications **Data Converters** dataconverter.ti.com Computers and Peripherals www.ti.com/computers **DLP® Products** www.dlp.com Consumer Electronics www.ti.com/consumer-apps

DSP **Energy and Lighting** dsp.ti.com www.ti.com/energy Clocks and Timers www.ti.com/clocks Industrial www.ti.com/industrial Interface interface.ti.com Medical www.ti.com/medical logic.ti.com Logic Security www.ti.com/security

Power Mgmt power.ti.com Space, Avionics and Defense www.ti.com/space-avionics-defense

Microcontrollers microcontroller.ti.com Video and Imaging www.ti.com/video

RFID www.ti-rfid.com

OMAP Applications Processors <a href="www.ti.com/omap">www.ti.com/omap</a> TI E2E Community <a href="e2e.ti.com">e2e.ti.com</a>

Wireless Connectivity <u>www.ti.com/wirelessconnectivity</u>